Application/Control No. Applicant(s)/Patent Under Reexamination 09/988,751 KWON ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 David W. Scheuermann 2834 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * 05-1993 US-5,208,498 Hamajima, Takanori 310/12 US-US-US-D US-Ε US-US-G US-Н US-US-US-K US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date * Classification Country Name Country Code-Number-Kind Code MM-YYYY N Q Q S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) ٧ W Χ

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